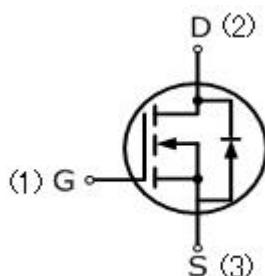


20N06(F,B,H)

20A mps,60 Volts N-CHANNEL MOSFET

FEATURE

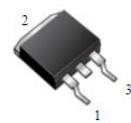
- 20A,60V, $R_{DS(ON)}=36m\Omega$ @ $V_{GS}=10V/10A$
- Low gate charge
- Low C_{iss}
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



TO-220AB
20N06



ITO-220AB
20N06F



TO-263
20N06B



TO-262
20N06H

Absolute Maximum Ratings($T_c=25^\circ C$,unless otherwise noted)

Parameter	Symbol	20N06	UNIT
Drain-Source Voltage	V_{DSS}	60	V
Gate-Source Voltage	V_{GSS}	± 20	
Continuous Drain Current	I_D	20	A
Pulsed Drain Current(Note1)	I_{DM}	80	
Single Pulse Avalanche Energy (Note 2)	E_{AS}	155	mJ
Avalanche Current(Note1)	I_{AR}	20	A
Repetitive Avalanche Energy (Note1)	E_{AR}	5.3	mJ
Reverse Diode dV/dt (Note 3)	dV/dt	7.0	V/ns
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to +150	°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	T_L	260	°C
Mounting Torque	6-32 or M3 screw	10	lbf • in
		1.1	N • m

Thermal Characteristics

Parameter	Symbol	ITO-220	TO-220	TO-262 TO-263	Units
Maximum Junction-to-Case	R_{thJC}	4	2	2	°C/W
Maximum Power Dissipation	$T_c=25^\circ C$	P_D	31.5	62.5	W

Electrical Characteristics ($T_c=25^\circ\text{C}$, unless otherwise noted)						
Parameter	Symbol	Test Conditions	Mix	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\text{uA}$	60	—	—	V
Breakdown Temperature Coefficient	$\Delta\text{BV}_{\text{DSS}}/\Delta T_J$	Reference to 25°C , $\text{I}_D=250\text{uA}$	—	0.5	—	$\text{V}/^\circ\text{C}$
Zero Gate Voltage Drain Current	I_{DSS}	$\text{V}_{\text{DS}}=60\text{V}, \text{V}_{\text{GS}}=0\text{V}$	—	—	1	uA
Gate-Body Leakage Current, Forward	I_{GSSF}	$\text{V}_{\text{GS}}=20\text{V}, \text{V}_{\text{DS}}=0\text{V}$	—	—	100	nA
Gate-Body Leakage Current, Reverse	I_{GSSR}	$\text{V}_{\text{GS}}=-20\text{V}, \text{V}_{\text{DS}}=0\text{V}$	—	—	-100	nA
On Characteristics						
Gate-Source Threshold Voltage	$\text{V}_{\text{GS(th)}}$	$\text{V}_{\text{DS}}=10\text{V}, \text{I}_D=250\text{uA}$	1.0	—	3.0	V
Drain-Source On-State Resistance	$\text{R}_{\text{DS(on)}}$	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=10\text{A}$	—	—	36	$\text{m}\Omega$
Dynamic Characteristics						
Input Capacitance	C_{iss}	$\text{V}_{\text{DS}}=25\text{V}, \text{V}_{\text{GS}}=0\text{V},$ $f=1.0\text{MHz}$	—	450	590	pF
Output Capacitance	C_{oss}		—	170	220	pF
Reverse Transfer Capacitance	C_{rss}		—	25	35	pF
Switching Characteristics						
Turn-On Delay Time	$t_{\text{d(on)}}$	$\text{V}_{\text{DD}}=30\text{V}, \text{I}_D=10\text{A},$ $R_G=25\Omega$ (Note 4,5)	—	5	20	ns
Turn-On Rise Time	t_r		—	45	100	ns
Turn-Off Delay Time	$t_{\text{d(off)}}$		—	20	50	ns
Turn-Off Fall Time	t_f		—	25	60	ns
Total Gate Charge	Q_g	$\text{V}_{\text{DS}}=48\text{V}, \text{I}_D=20\text{A},$ $\text{V}_{\text{GS}}=10\text{V}$ (Note 4,5)	—	11.5	15	nC
Gate-Source Charge	Q_{gs}		—	3	—	nC
Gate-Drain Charge	Q_{gd}		—	4.5	—	nC
Drain-Source Body Diode Characteristics and Maximum Ratings						
Continuous Diode Forward Current	I_S		—	—	20	A
Pulsed Diode Forward Current	I_{SM}		—	—	80	A
Diode Forward Voltage	V_{SD}	$I_S=20\text{A}, \text{V}_{\text{GS}}=0\text{V}$	—	—	1.5	V
Reverse Recovery Time	t_{rr}	$\text{V}_{\text{GS}}=0\text{V}, I_S=20\text{A},$ $dI_F/dt=100\text{A/us}$ (Note 4)	—	43	—	ns
Reverse Recovery Charge	Q_{rr}		—	50	—	uC

Notes

- Repetitive Rating: pulse width limited by maximum junction temperature.
- $\text{V}_{\text{DD}}=10\text{V}, L=1\text{mH}, R_g=25\Omega, I_{AS}=20\text{A}, T_J=25^\circ\text{C}$.
- $I_{SD} \leq I_D, dI/dt=200\text{A/us}, V_{DD} \leq \text{BV}_{\text{DSS}}$, starting $T_J=25^\circ\text{C}$.
- Pulse width $\leq 300\text{us}$; duty cycle $\leq 2\%$.
- Repetitive rating; pulse width limited by maximum junction temperature.